

SLV8205T

20V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

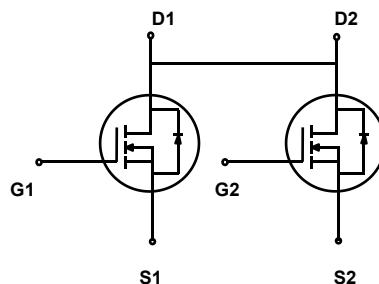
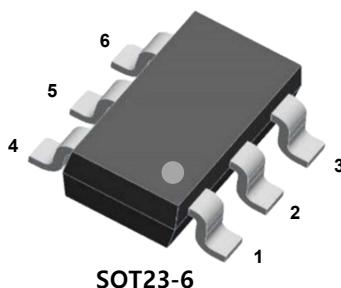
Application

- PWM Application
- Load Switch
- Power Management

Features

- N-Channel: 20V 5A
- $R_{DS(on)Typ} = 19m\Omega @ V_{GS} = 4.5V$
- $R_{DS(on)Typ} = 26m\Omega @ V_{GS} = 2.5V$
- Very Low On-resistance $R_{DS(ON)}$
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

Package



Pin description

1	S1
2	D1
3	S2
4	G1
5	D2
6	G2

Absolute Maximum Ratings

$T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter	SLV8205T	Units
V_{DSS}	Drain-Source Voltage	20	V
I_D	Drain Current - Continuous ($T_C = 25^\circ C$)	5	A
	- Continuous ($T_C = 100^\circ C$)	3	A
I_{DM}	Drain Current - Pulsed	(Note 1)	A
V_{GSS}	Gate-Source Voltage	± 12	V
P_D	Power Dissipation ($T_C = 25^\circ C$)	1.25	W
$R_{\theta JA}$	Thermal Resistance, Junction to Case	100	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

* Drain current limited by maximum junction temperature.

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLV8205T	8205	SOT23-6	Tape & Reel	3000	180000

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	19.5	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 19 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1.0	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 12 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -12 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	0.45	0.65	1.2	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 4.5 \text{ V}, I_D = 4 \text{ A}$	--	19	24	$\text{m}\Omega$
		$V_{\text{GS}} = 2.5 \text{ V}, I_D = 3 \text{ A}$	--	26	35	$\text{m}\Omega$

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 8 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	306	-	pF
C_{oss}	Output Capacitance		--	70	-	pF
C_{rss}	Reverse Transfer Capacitance		--	65	-	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}} = 4.5 \text{ V}, V_{\text{DS}} = 10 \text{ V}, R_G = 10 \Omega, I_D = 1 \text{ A}$	--	18	--	ns
t_r	Turn-On Rise Time		--	5	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	43.8	--	ns
t_f	Turn-Off Fall Time		--	20	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 10 \text{ V}, I_D = 4 \text{ A}, V_{\text{GS}} = 4.5 \text{ V}$	--	4.6	--	nC
Q_{gs}	Gate-Source Charge		--	0.5	--	nC
Q_{gd}	Gate-Drain Charge		--	1.9	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	5	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	20	A
V_{SD}	Drain to Source Diode Forward Voltage, $V_{\text{GS}} = 0 \text{ V}, I_{\text{SD}} = 4 \text{ A}, T_J = 25^\circ\text{C}$	--	--	1.2	V

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 0.5\%$

N-Channel Typical Characteristics

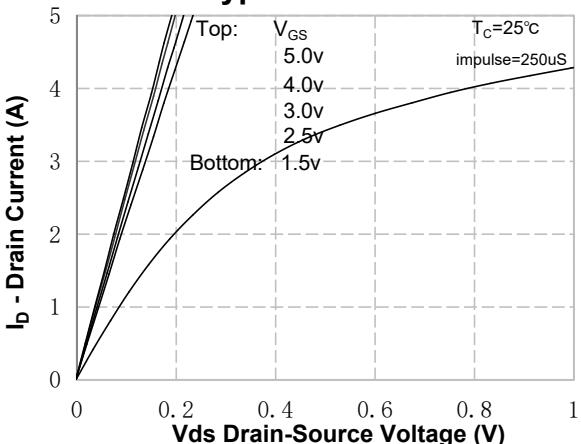


Figure 1. On-Region Characteristics

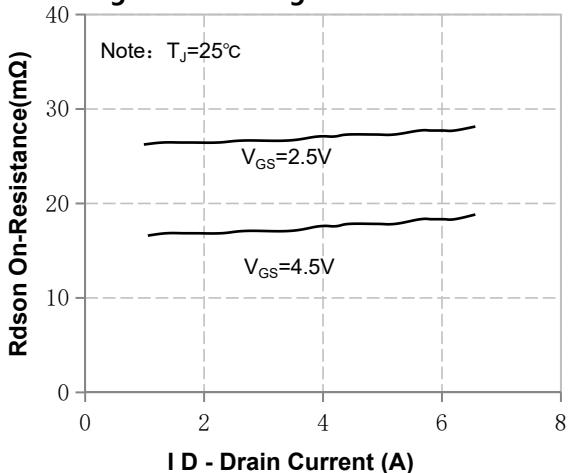


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

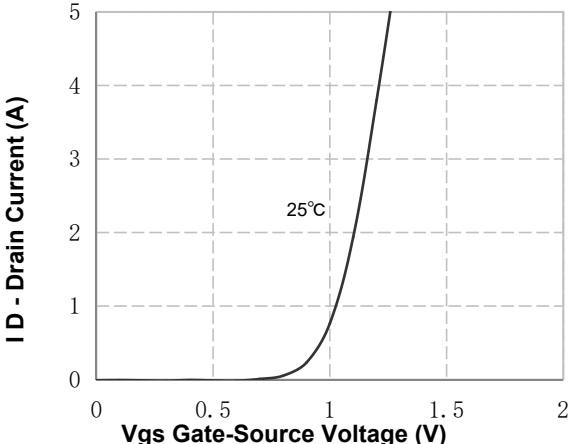


Figure 2. Transfer Characteristics

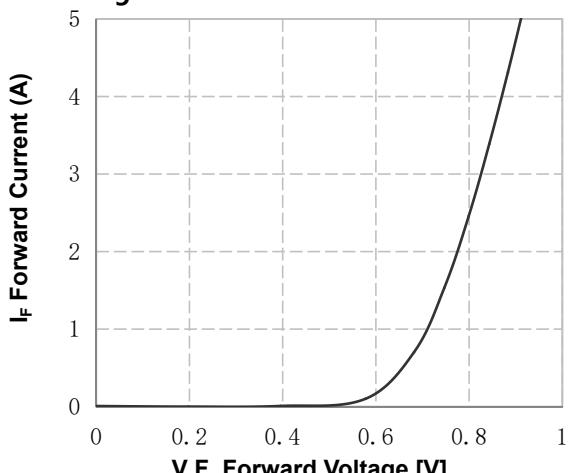


Figure 4. Body Diode Forward Voltage Variation with Source Current

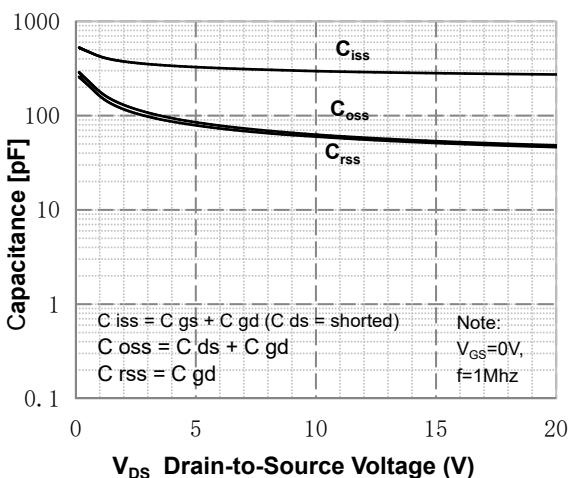


Figure 5. Capacitance Characteristics

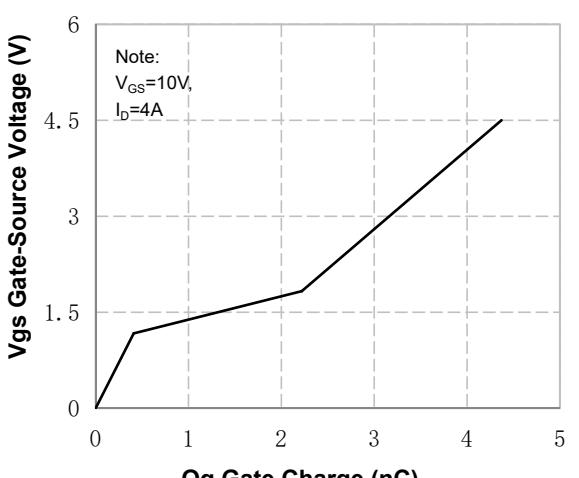
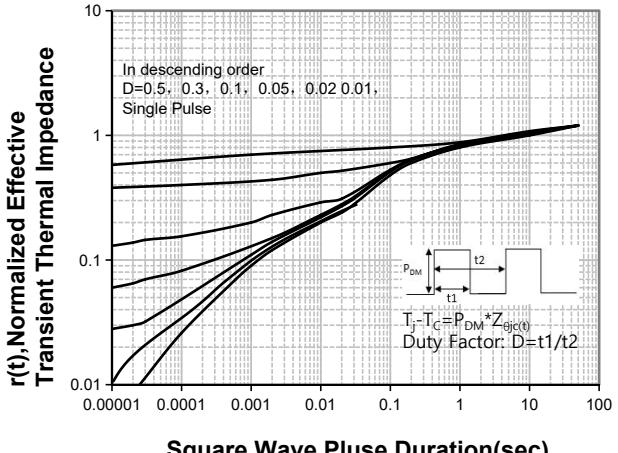
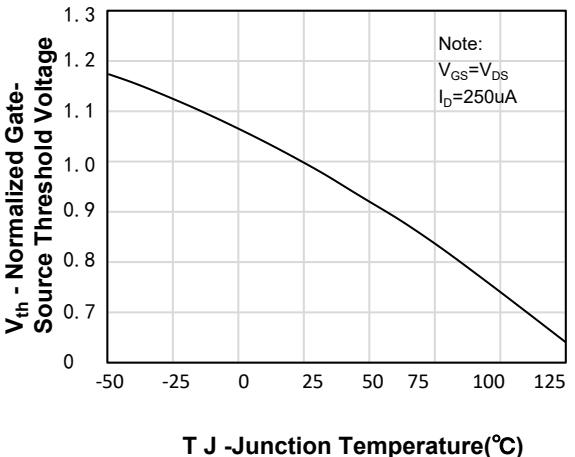
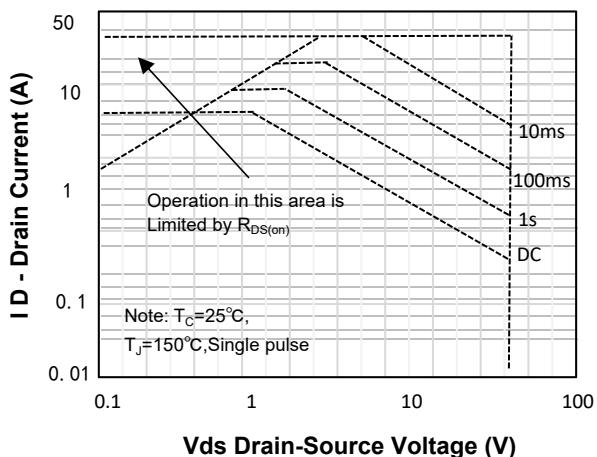
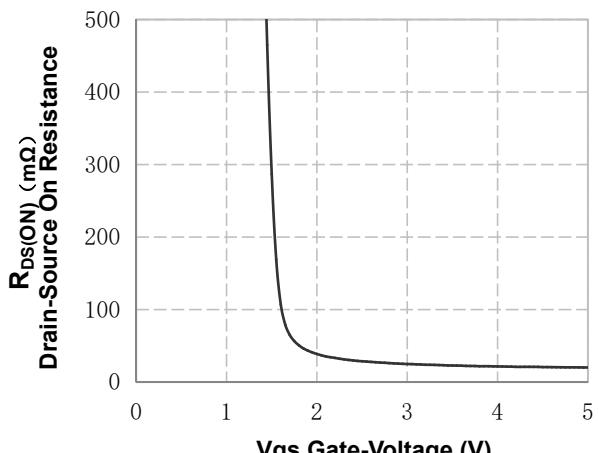
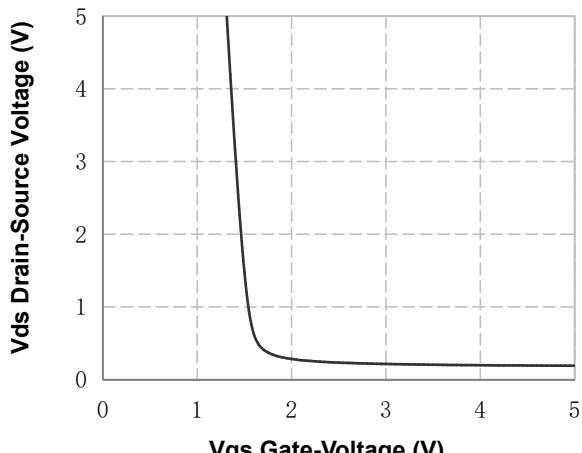
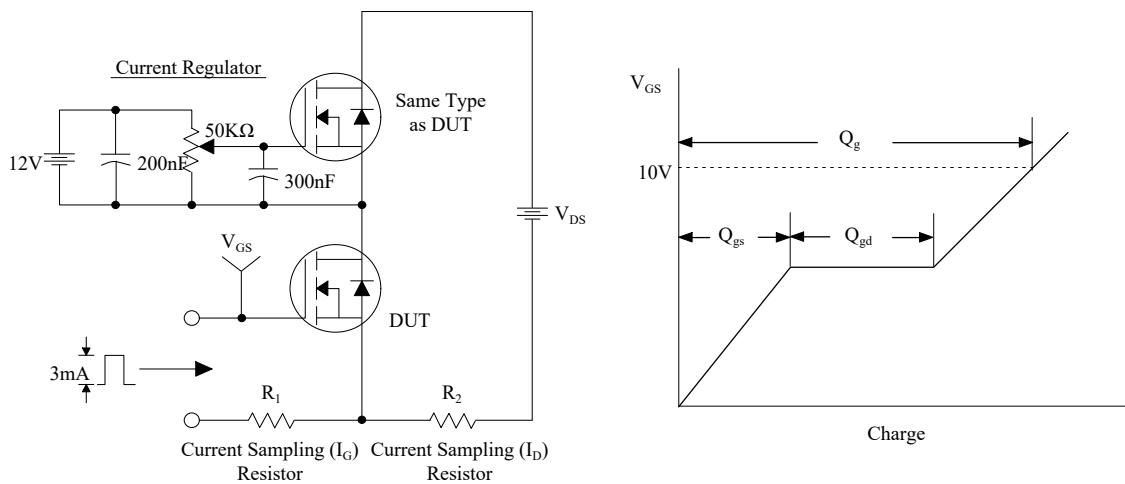


Figure 6. Gate Charge Characteristics

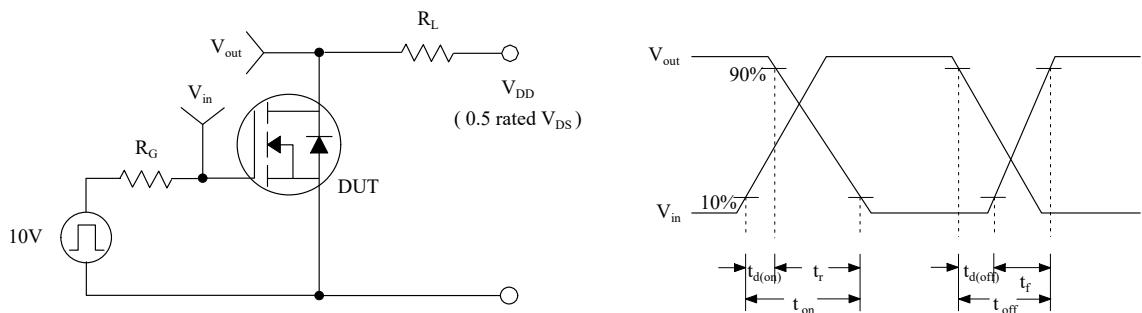
N-Channel Typical Characteristics (Continued)



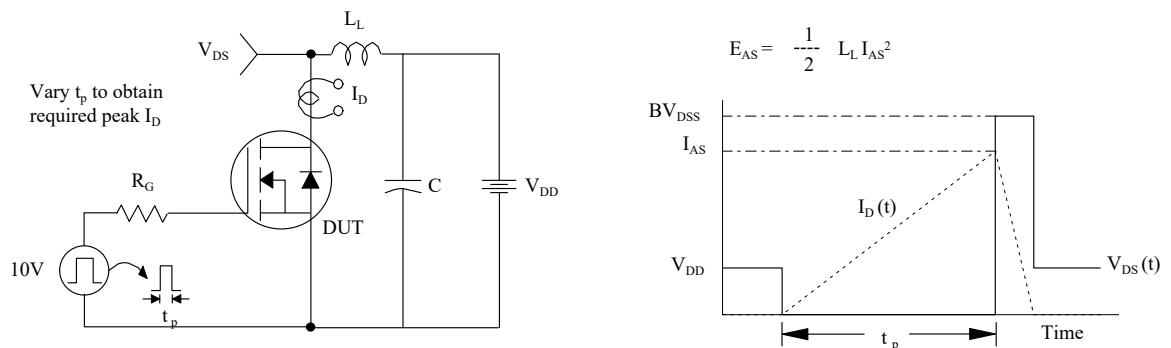
Gate Charge Test Circuit & Waveform



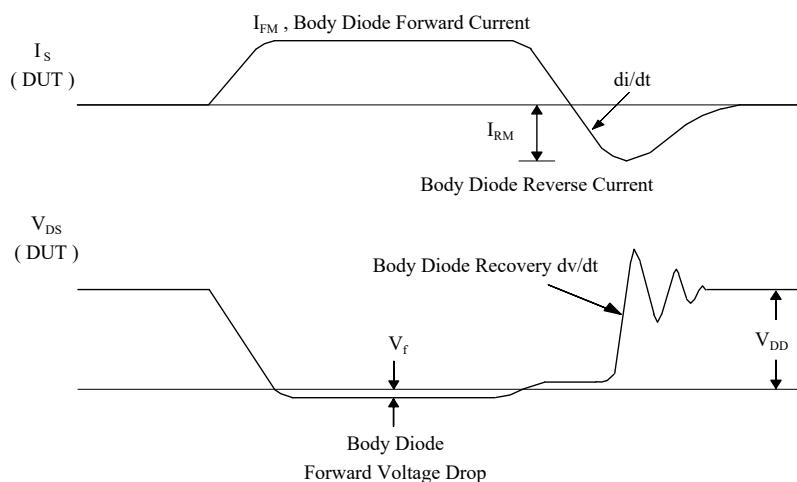
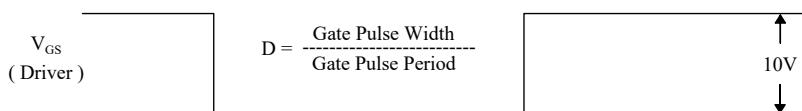
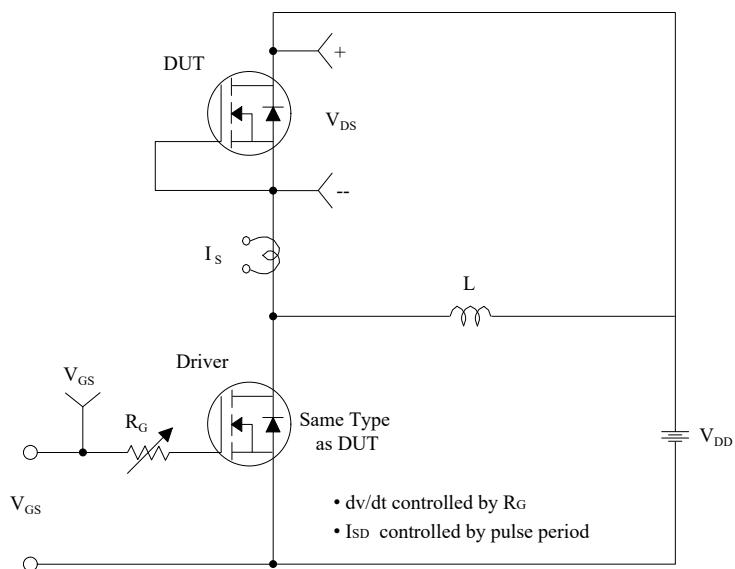
Resistive Switching Test Circuit & Waveforms



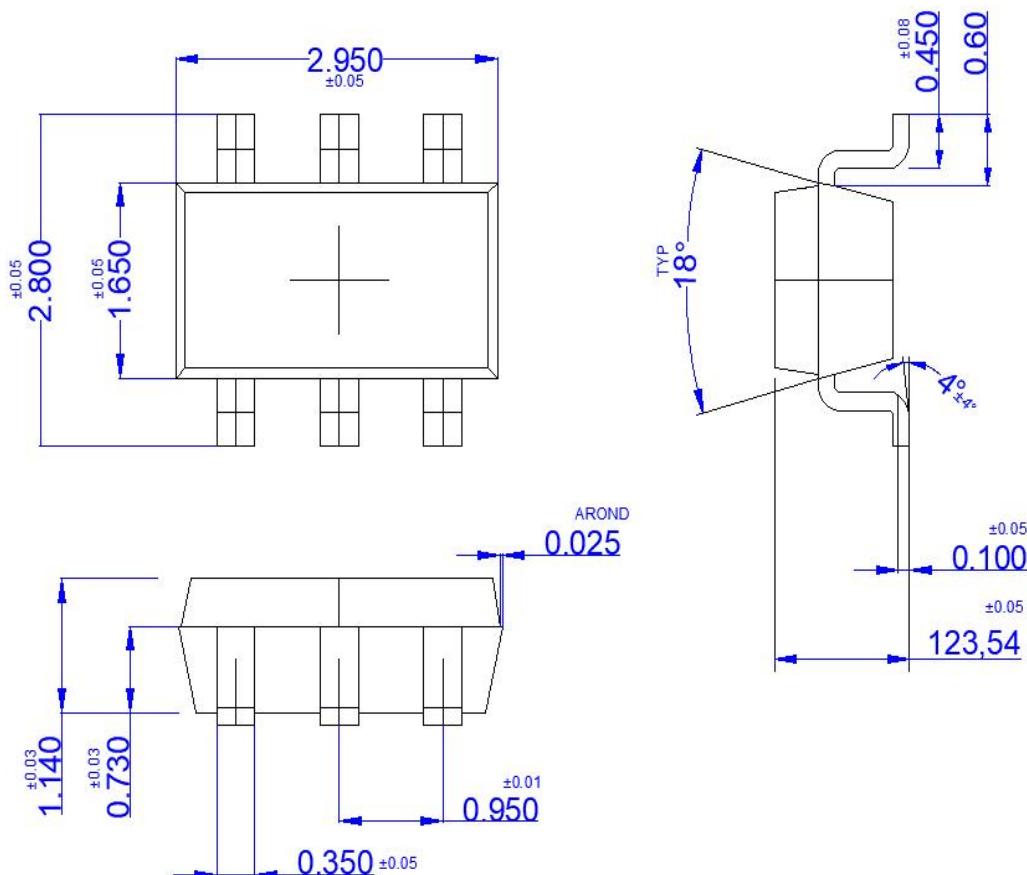
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms



SOT23-6 OUTLINE

**NOTE:**

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance ± 0.25 ,Unmarked filletRmax=0.25

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